

### General Description

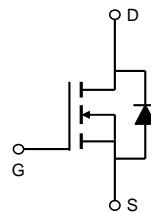
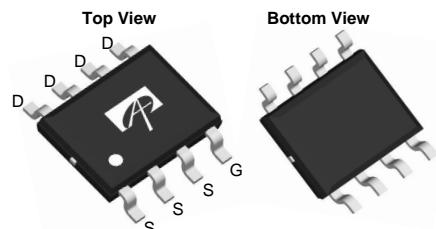
The AO4442 uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and operation with gate voltages from 4.5V to 25V. This device is suitable for use as a load switch or in PWM applications.

### Product Summary

|                                    |         |
|------------------------------------|---------|
| $V_{DS}$                           | 75V     |
| $I_D$ (at $V_{GS}=10V$ )           | 3.1A    |
| $R_{DS(ON)}$ (at $V_{GS}=10V$ )    | < 130mΩ |
| $R_{DS(ON)}$ (at $V_{GS} = 4.5V$ ) | < 165mΩ |



SOIC-8



### Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

| Parameter                              | Symbol         | Maximum    | Units |
|--|----------------|------------|-------|
| Drain-Source Voltage                   | $V_{DS}$       | 75         | V     |
| Gate-Source Voltage                    | $V_{GS}$       | $\pm 25$   | V     |
| Continuous Drain Current               | $I_D$          | 3.1        | A     |
| $T_A=70^\circ C$                       |                | 2.5        |       |
| Pulsed Drain Current <sup>C</sup>      | $I_{DM}$       | 20         |       |
| $T_A=25^\circ C$                       | $P_D$          | 3.1        | W     |
| $T_A=70^\circ C$                       |                | 2          |       |
| Junction and Storage Temperature Range | $T_J, T_{STG}$ | -55 to 150 | °C    |

### Thermal Characteristics

| Parameter   | Symbol          | Typ | Max | Units |
|---|-----------------|-----|-----|-------|
| Maximum Junction-to-Ambient <sup>A</sup>                | $R_{\theta JA}$ | 31  | 40  | °C/W  |
| Maximum Junction-to-Ambient <sup>A,D</sup> Steady-State |                 | 59  | 75  | °C/W  |
| Maximum Junction-to-Lead                                | $R_{\theta JL}$ | 16  | 24  | °C/W  |

**Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)**

| Symbol                      | Parameter                             | Conditions   | Min | Typ        | Max        | Units            |
|-----------------------------|---------------------------------------|--|-----|------------|------------|------------------|
| <b>STATIC PARAMETERS</b>    |                                       |  |     |            |            |                  |
| $\text{BV}_{\text{DSS}}$    | Drain-Source Breakdown Voltage        | $I_D=10\text{mA}$ , $V_{GS}=0\text{V}$   | 75  |            |            | V                |
| $I_{\text{DSS}}$            | Zero Gate Voltage Drain Current       | $V_{DS}=60\text{V}$ , $V_{GS}=0\text{V}$<br>$T_J=55^\circ\text{C}$                         |     |            | 1<br>5     | $\mu\text{A}$    |
| $I_{\text{GSS}}$            | Gate-Body leakage current             | $V_{DS}=0\text{V}$ , $V_{GS}=\pm 25\text{V}$   |     |            | 100        | nA               |
| $V_{\text{GS(th)}}$         | Gate Threshold Voltage                | $V_{DS}=V_{GS}$ , $I_D=250\mu\text{A}$   | 1   | 2.4        | 3          | V                |
| $I_{\text{D(ON)}}$          | On state drain current                | $V_{GS}=10\text{V}$ , $V_{DS}=5\text{V}$   | 20  |            |            | A                |
| $R_{\text{DS(ON)}}$         | Static Drain-Source On-Resistance     | $V_{GS}=10\text{V}$ , $I_D=3.1\text{A}$<br>$T_J=125^\circ\text{C}$                         |     | 100<br>180 | 130<br>220 | $\text{m}\Omega$ |
|                             |                                       | $V_{GS}=4.5\text{V}$ , $I_D=2\text{A}$   |     | 120        | 165        | $\text{m}\Omega$ |
| $g_{\text{FS}}$             | Forward Transconductance              | $V_{DS}=5\text{V}$ , $I_D=3.1\text{A}$   |     | 8.2        |            | S                |
| $V_{\text{SD}}$             | Diode Forward Voltage                 | $I_S=1\text{A}$ , $V_{GS}=0\text{V}$   |     | 0.79       | 1          | V                |
| $I_S$                       | Maximum Body-Diode Continuous Current |  |     |            | 3.5        | A                |
| <b>DYNAMIC PARAMETERS</b>   |                                       |  |     |            |            |                  |
| $C_{\text{iss}}$            | Input Capacitance                     | $V_{GS}=0\text{V}$ , $V_{DS}=37.5\text{V}$ , $f=1\text{MHz}$                               |     | 303        | 350        | pF               |
| $C_{\text{oss}}$            | Output Capacitance                    |  |     | 37         |            | pF               |
| $C_{\text{rss}}$            | Reverse Transfer Capacitance          |  |     | 17         |            | pF               |
| $R_g$                       | Gate resistance                       | $V_{GS}=0\text{V}$ , $V_{DS}=0\text{V}$ , $f=1\text{MHz}$                                  |     | 2.2        | 3          | $\Omega$         |
| <b>SWITCHING PARAMETERS</b> |                                       |  |     |            |            |                  |
| $Q_g(10\text{V})$           | Total Gate Charge                     | $V_{GS}=10\text{V}$ , $V_{DS}=37.5\text{V}$ , $I_D=3.1\text{A}$                            |     | 5.2        | 6.5        | nC               |
| $Q_g(4.5\text{V})$          | Total Gate Charge                     |  |     | 2.46       | 3.5        | nC               |
| $Q_{gs}$                    | Gate Source Charge                    |  |     | 1          |            | nC               |
| $Q_{gd}$                    | Gate Drain Charge                     |  |     | 1.34       |            | nC               |
| $t_{\text{D(on)}}$          | Turn-On Delay Time                    | $V_{GS}=10\text{V}$ , $V_{DS}=37.5\text{V}$ , $R_L=12\Omega$ ,<br>$R_{\text{GEN}}=3\Omega$ |     | 4.5        |            | ns               |
| $t_r$                       | Turn-On Rise Time                     |  |     | 2.3        |            | ns               |
| $t_{\text{D(off)}}$         | Turn-Off Delay Time                   |  |     | 15.6       |            | ns               |
| $t_f$                       | Turn-Off Fall Time                    |  |     | 1.9        |            | ns               |
| $t_{\text{rr}}$             | Body Diode Reverse Recovery Time      | $I_F=3.1\text{A}$ , $dI/dt=100\text{A}/\mu\text{s}$  |     | 22         | 30         | ns               |
| $Q_{\text{rr}}$             | Body Diode Reverse Recovery Charge    | $I_F=3.1\text{A}$ , $dI/dt=100\text{A}/\mu\text{s}$  |     | 22         |            | nC               |

A. The value of  $R_{\text{0JA}}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The value in any given application depends on the user's specific board design.

B. The power dissipation  $P_D$  is based on  $T_{J(\text{MAX})}=150^\circ\text{C}$ , using  $\leq 10\text{s}$  junction-to-ambient thermal resistance.

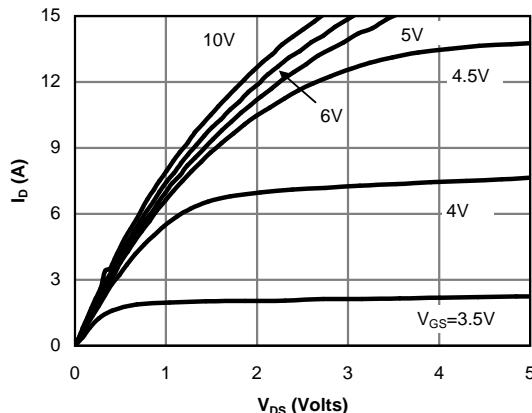
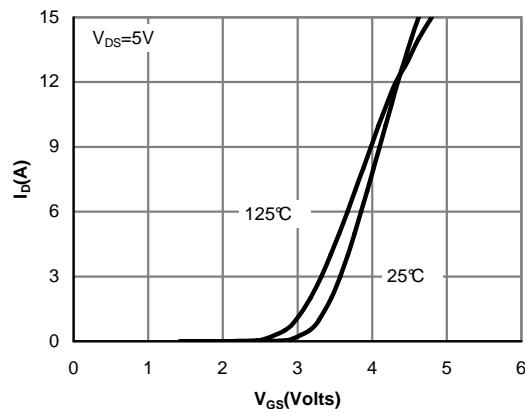
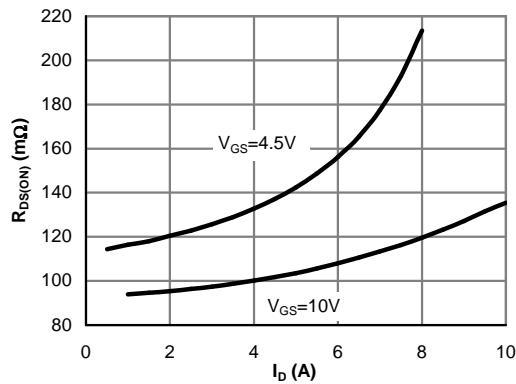
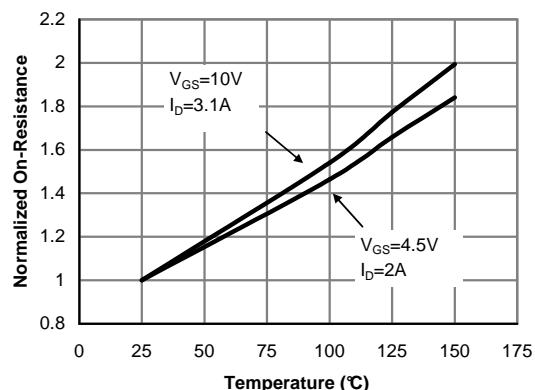
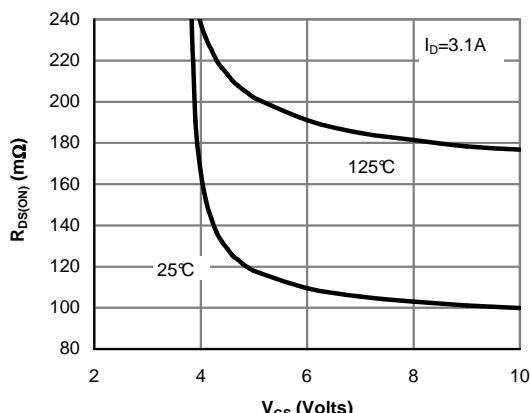
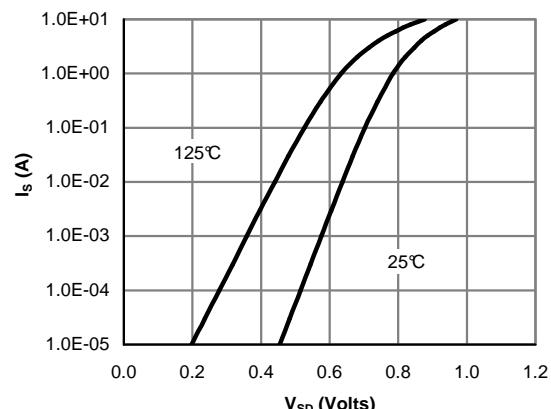
C. Repetitive rating, pulse width limited by junction temperature  $T_{J(\text{MAX})}=150^\circ\text{C}$ . Ratings are based on low frequency and duty cycles to keep initial  $T_J=25^\circ\text{C}$ .

D. The  $R_{\text{0JA}}$  is the sum of the thermal impedance from junction to lead  $R_{\text{0UL}}$  and lead to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-ambient thermal impedance which is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, assuming a maximum junction temperature of  $T_{J(\text{MAX})}=150^\circ\text{C}$ . The SOA curve provides a single pulse rating.

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**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

**Fig 1: On-Region Characteristics (Note E)**

**Figure 2: Transfer Characteristics (Note E)**

**Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)**

**Figure 4: On-Resistance vs. Junction Temperature (Note E)**

**Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)**

**Figure 6: Body-Diode Characteristics (Note E)**

### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

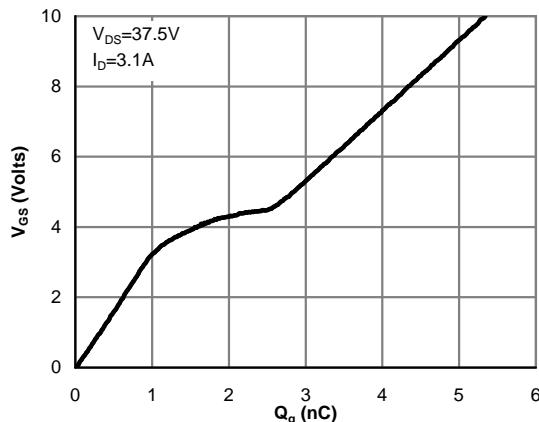


Figure 7: Gate-Charge Characteristics

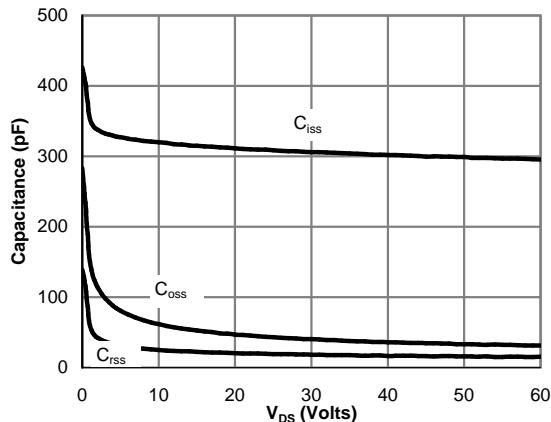


Figure 8: Capacitance Characteristics

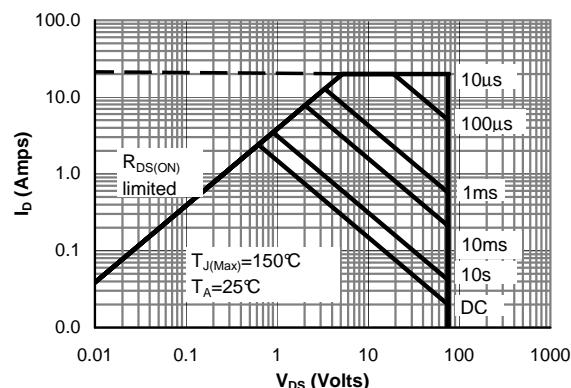


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

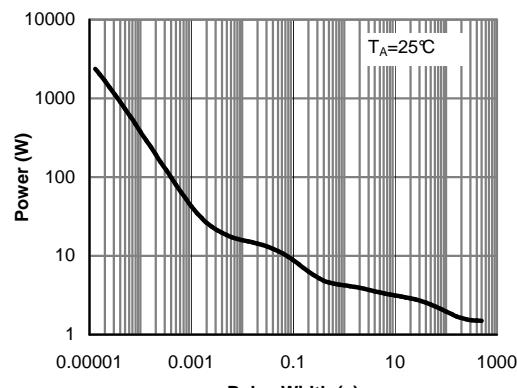


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note F)

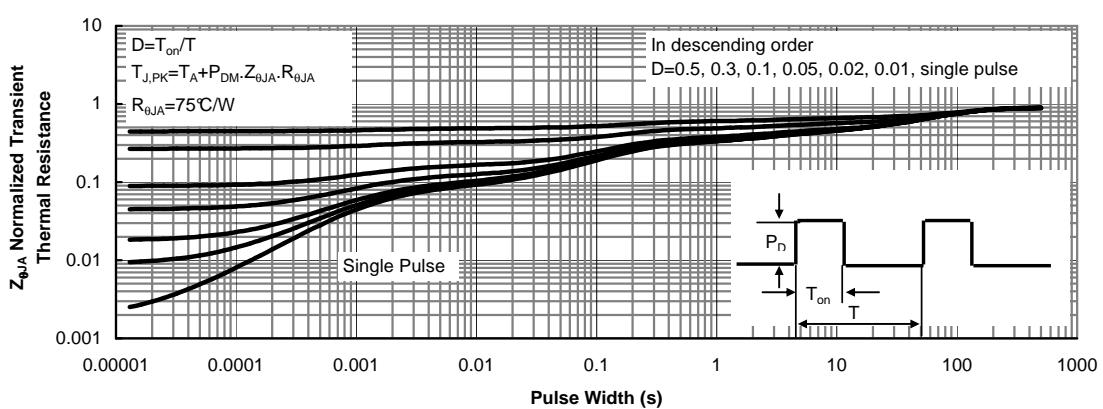
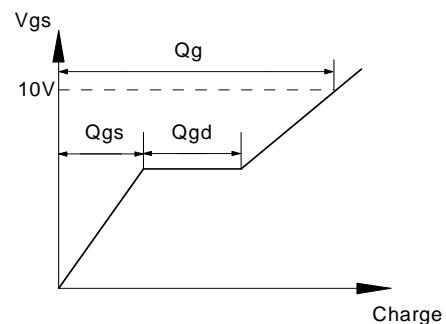
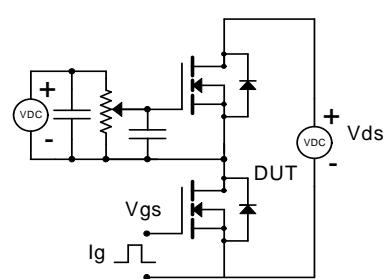
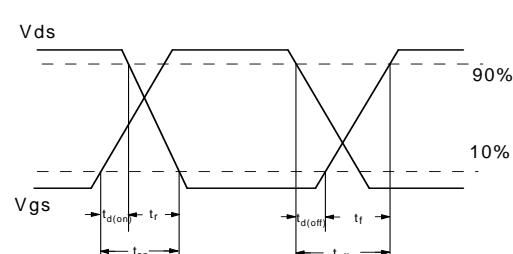
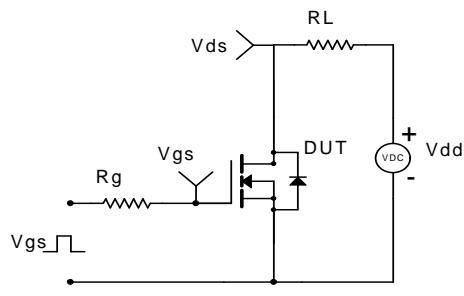


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

**Gate Charge Test Circuit & Waveform**

**Resistive Switching Test Circuit & Waveforms**

**Diode Recovery Test Circuit & Waveforms**
